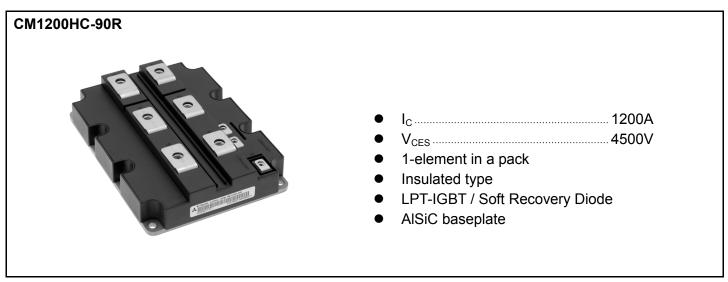


< HVIGBT MODULES >

### CM1200HC-90R

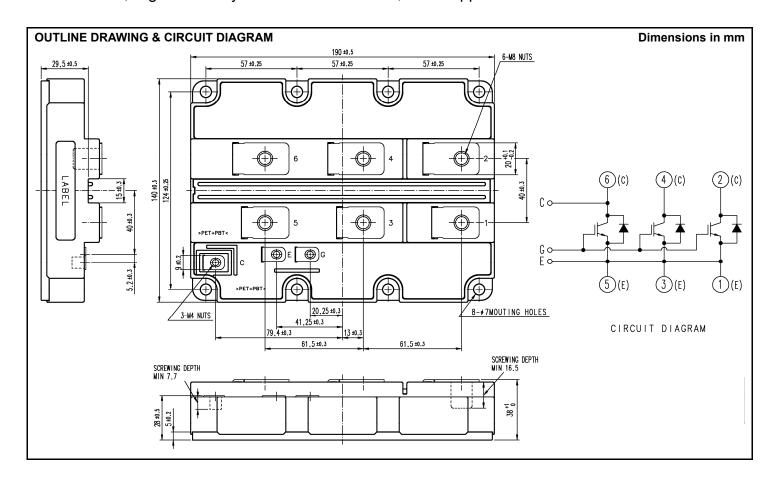
HIGH POWER SWITCHING USE INSULATED TYPE

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules



#### **APPLICATION**

Traction drives, High Reliability Converters / Inverters, DC choppers



# HIGH POWER SWITCHING USE INSULATED TYPE

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

#### **MAXIMUM RATINGS**

Symbol	Item	Conditions	Ratings	Unit
V <sub>CES</sub>	Collector-emitter voltage	$V_{GE} = 0V, T_j = -40+125^{\circ}C$	4500	V
		$V_{GE} = 0V, T_j = -50^{\circ}C$	4400	v
$V_{GES}$	Gate-emitter voltage	$V_{CE} = 0V, T_j = 25^{\circ}C$	±20	V
Ic	Collector ourrent	DC, $T_c = 85^{\circ}C$	1200	Α
I <sub>CRM</sub>	Collector current	Pulse (Note 1)	2400	Α
IE	Emitter current (Note 2)	DC	1200	Α
I <sub>ERM</sub>	Emitter current (Note 2)	Pulse (Note 1)	2400	Α
P <sub>tot</sub>	Maximum power dissipation (Note 3)	T <sub>c</sub> = 25°C, IGBT part	12500	W
V <sub>iso</sub>	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1 min.	6000	V
V <sub>e</sub>	Partial discharge extinction voltage	RMS, sinusoidal, f = 60Hz, Q <sub>PD</sub> ≤ 10 pC	3500	V
Tj	Junction temperature		<b>−</b> 50 ~ <b>+</b> 150	°C
T <sub>jop</sub>	Operating junction temperature		-50 ~ +125	°C
$T_{stg}$	Storage temperature		<b>−</b> 55 ~ <b>+</b> 125	°C
t <sub>psc</sub>	Short circuit pulse width	$V_{CC} = 3200V, V_{CE} \le V_{CES}, V_{GE} = 15V, T_j = 125^{\circ}C$	10	μS

### **ELECTRICAL CHARACTERISTICS**

Cumphal	lla	Conditions	Conditions		Limits		
Symbol	Item	Conditions		Min	Тур	Max	Unit
1	Collector cutoff current	$V_{CE} = V_{CES}, V_{GE} = 0V$	T <sub>j</sub> = 25°C	_	_	16.0	mA
I <sub>CES</sub>			T <sub>j</sub> = 125°C		16.0	1	IIIA
$V_{GE(th)}$	Gate-emitter threshold voltage	$V_{CE} = 10 \text{ V}, I_{C} = 120 \text{ mA}, T_{j} = 25^{\circ}\text{C}$		5.8	6.3	6.8	٧
$I_{GES}$	Gate leakage current	$V_{GE} = V_{GES}, V_{CE} = 0V, T_j = 25^{\circ}C$		-0.5	_	0.5	μΑ
Cies	Input capacitance	V <sub>CF</sub> = 10 V, V <sub>GF</sub> = 0 V, f = 100 kHz			175.0	-	nF
C <sub>oes</sub>	Output capacitance	$T_i = 25^{\circ}C$		_	11.0	_	nF
C <sub>res</sub>	Reverse transfer capacitance	1j - 25 C			5.0	1	nF
$Q_{G}$	Total gate charge	$V_{CC}$ = 2800V, $I_{C}$ = 1200A, $V_{GE}$ = ±15V		1	13.5	1	μC
V	Callantar are itter and unation waltern	I <sub>C</sub> = 1200 A <sup>(Note 4)</sup>	T <sub>j</sub> = 25°C	_	3.50		V
$V_{CEsat}$	Collector-emitter saturation voltage	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 125°C	_	4.40	5.10	
+	Turn-on delay time		T <sub>j</sub> = 25°C	-	1.00		
$t_{d(on)}$		V <sub>CC</sub> = 2800 V	T <sub>j</sub> = 125°C		0.95	1.50	
4	Turn-on rise time	I <sub>C</sub> = 1200 A	T <sub>j</sub> = 25°C	_	0.28		
t <sub>r</sub>	Turn-on rise time	V <sub>GE</sub> = ±15 V	T <sub>j</sub> = 125°C	1	0.30	0.50	μs
_	Turn-on switching energy (Note 5)	$R_{G(on)} = 2.7 \Omega$	$T_j = 25^{\circ}C$		4.30	1	J
E <sub>on(10%)</sub>	Turn-on switching energy	L <sub>s</sub> = 150 nH	T <sub>j</sub> = 125°C		5.10	1	J
Eon	Turn-on switching energy (Note 6)	Inductive load	$T_j = 25^{\circ}C$		4.60	-	J/P
∟on	Turn-on switching energy		T <sub>j</sub> = 125°C	_	5.50	_	J/F
4	Turn-off delay time		$T_j = 25^{\circ}C$	_	3.60	_	110
$t_{\sf d(off)}$	Turn-on delay time	V <sub>CC</sub> = 2800 V	T <sub>j</sub> = 125°C	1	3.80	5.00	μs
4	Turn-off fall time	I <sub>C</sub> = 1200 A	$T_j = 25^{\circ}C$		0.35	1	
t <sub>f</sub>	Turn-on fall time	V <sub>GE</sub> = ±15 V	T <sub>j</sub> = 125°C	-	0.45	1.00	μs
	Turn-off switching energy (Note 5)	$R_{G(off)} = 10 \Omega$	T <sub>j</sub> = 25°C	-	2.90		J
E <sub>off(10%)</sub>	rum-on switching energy	L <sub>s</sub> = 150 nH	T <sub>j</sub> = 125°C	_	3.85	_	J
E <sub>off</sub>	Turn off switching operay (Note 6)	Inductive load	T <sub>j</sub> = 25°C	_	3.20	_	J
Loff	Turn-off switching energy (Note 6)		T <sub>j</sub> = 125°C	_	4.30	_	J

#### < HVIGBT MODULES >

### CM1200HC-90R

### HIGH POWER SWITCHING USE INSULATED TYPE

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

#### **ELECTRICAL CHARACTERISTICS (continuation)**

Symbol	Item		Conditions	Conditions		Limits		
Syllibol	Symbol				Min	Тур	Max	Unit
W	Emitter collector voltage	(Note 2)	I <sub>E</sub> = 1200 A <sup>(Note 4)</sup>	$T_j = 25^{\circ}C$	_	2.50	1	V
V <sub>EC</sub>	Emitter-collector voltage (Note 2)		V <sub>GE</sub> = 0 V	T <sub>j</sub> = 125°C	_	2.80	3.40	V
+	(Note 2)	(Note 2)		T <sub>j</sub> = 25°C	_	0.70	_	
t <sub>rr</sub>	Reverse recovery time	se recovery time		T <sub>j</sub> = 125°C	_	0.90	1	μs
	Devices a second (No	(Note 2)	ote 2) V <sub>CC</sub> = 2800 V	$T_j = 25^{\circ}C$	_	1100	1	Α
Irr	Reverse recovery current		I <sub>C</sub> = 1200 A	T <sub>j</sub> = 125°C	_	1200	1	A
Q <sub>rr</sub>	Reverse recovery charge	(Note 2)	V <sub>GE</sub> = ±15 V	$T_j = 25^{\circ}C$	_	1000	ı	μC
Q <sub>rr</sub>	Reverse recovery charge		$R_{G(on)} = 2.7 \Omega$	T <sub>j</sub> = 125°C	_	1500	1	μΟ
_	Reverse recovery energy	(Note 2)	L <sub>s</sub> = 150 nH	$T_j = 25^{\circ}C$	_	1.30	1	
E <sub>rec(10%)</sub>		(Note 5)	Inductive load	T <sub>j</sub> = 125°C	_	2.10	1	J
_	Reverse recovery energy	(Note 2)		T <sub>j</sub> = 25°C	_	1.55	_	
E <sub>rec</sub>		(Note 6)		T <sub>j</sub> = 125°C	_	2.40		J

#### THERMAL CHARACTERISTICS

Symbol	Item	Conditions		Limits		
Syllibol				Тур	Max	Unit
$R_{th(j-c)Q}$	Thermal resistance	Junction to Case, IGBT part	-	1	10.0	K/kW
R <sub>th(j-c)D</sub>	Thermal resistance	Junction to Case, FWDi part	1		19.0	K/kW
R <sub>th(c-s)</sub>	Contact thermal resistance	Case to heat sink, $\lambda_{grease} = 1W/m^*k$ , $D_{(c-s)} = 100\mu m$	_	6.0	_	K/kW

### **MECHANICAL CHARACTERISTICS**

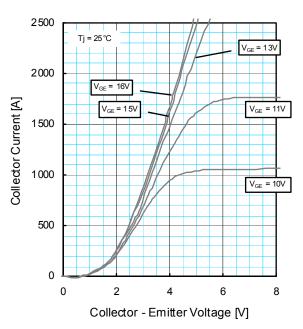
Symbol	Item	Conditions	Limits			Unit
			Min	Тур	Max	UIIIL
M <sub>t</sub>		M8 : Main terminals screw	7.0	ı	22.0	N·m
Ms	Mounting torque	M6 : Mounting screw	3.0	ı	6.0	N·m
$M_t$		M4 : Auxiliary terminals screw	1.0	ı	3.0	N·m
m	Mass		_	1.2	-	kg
CTI	Comparative tracking index		600	1	1	_
d <sub>a</sub>	Clearance		19.5	ı	l	mm
d <sub>s</sub>	Creepage distance		32.0	1		mm
L <sub>P CE</sub>	Parasitic stray inductance		1	11.0	1	nΗ
R <sub>CC'+EE'</sub>	Internal lead resistance	T <sub>C</sub> = 25°C	1	0.12	-	mΩ
r <sub>g</sub>	Internal gate resistance	$T_C = 25^{\circ}C$	-	1.7	1	Ω

Note1. Pulse width and repetition rate should be such that junction temperature (T<sub>i</sub>) does not exceed T<sub>opmax</sub> rating.

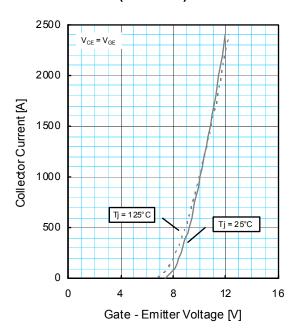
- 2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD<sub>i</sub>).
- 3. Junction temperature (T<sub>j</sub>) should not exceed T<sub>jmax</sub> rating (150°C).
- 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.
- 5.  $E_{on(10\%)}$  /  $E_{off(10\%)}$  /  $E_{rec(10\%)}$  are the integral of 0.1 $V_{CE}$  x 0.1 $I_{C}$  x dt.
- 6. Definition of all items is according to IEC 60747, unless otherwise specified.

#### **PERFORMANCE CURVES**

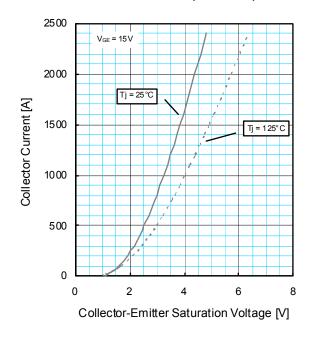
# OUTPUT CHARACTERISTICS (TYPICAL)



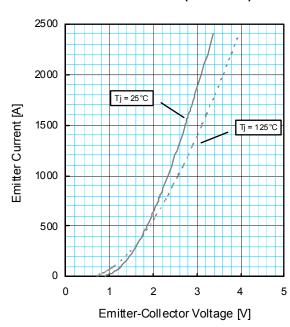
# TRANSFER CHARACTERISTICS (TYPICAL)



## COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



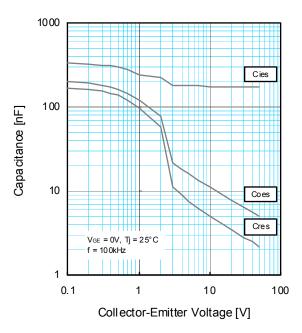
# FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)



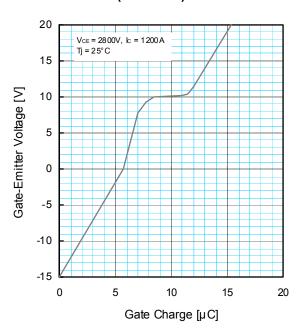
#### **PERFORMANCE CURVES**

**INSULATED TYPE** 

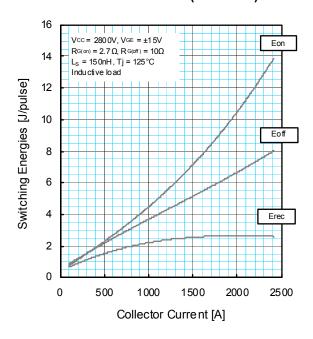
# CAPACITANCE CHARACTERISTICS (TYPICAL)



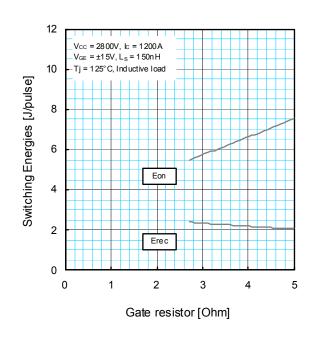
# GATE CHARGE CHARACTERISTICS (TYPICAL)



# HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



# HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)

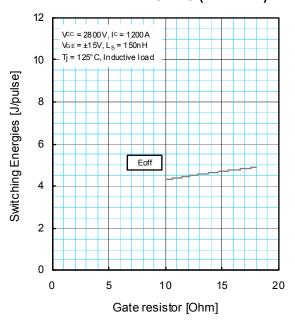


**HIGH POWER SWITCHING USE** 

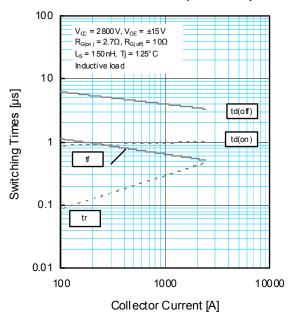
### PERFORMANCE CURVES

**INSULATED TYPE** 

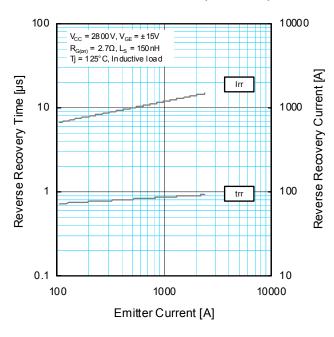
# HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



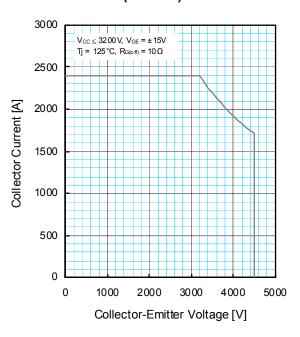
## HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



# FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



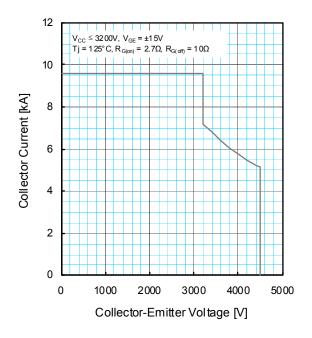
# REVERSE BIAS SAFE OPERATING AREA (RBSOA)



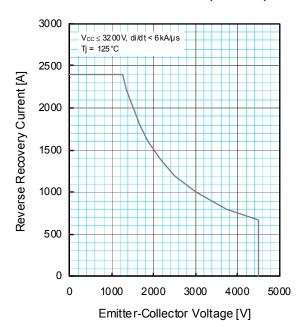
#### **PERFORMANCE CURVES**

**INSULATED TYPE** 

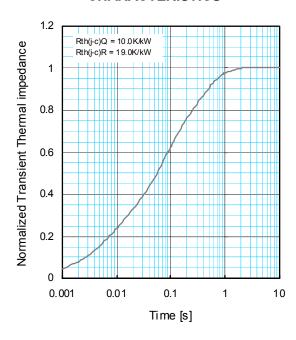
# SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



# FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



## TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



$Z_{\it th()}$	$_{i-c)}(t)=\sum_{i}^{\infty}$	$\sum_{i=1}^{n} R_i \left\{ 1 - \frac{1}{2} \right\}$	$-exp^{-\frac{1}{2}}$	$\left\{ \frac{t}{T_i} \right\}$
	1	2	3	4
R <sub>i</sub> [K/kW]:	0.0096	0.1893	0.4044	0.3967
t <sub>i</sub> [sec]:	0.0001	0.0058	0.0602	0.3512

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